COXEM

Product Catalog

www.coxem.com



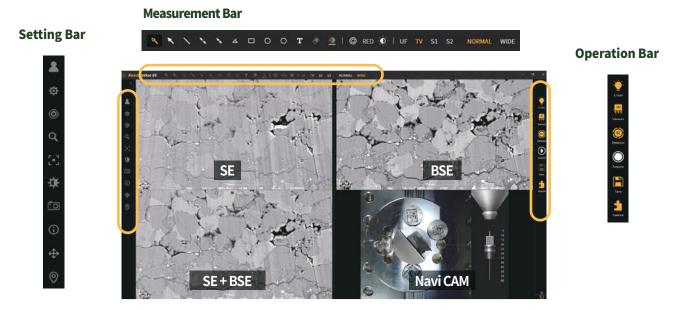
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COXEM'S NEW SEMS EM-40 / CX-200K / CX-300



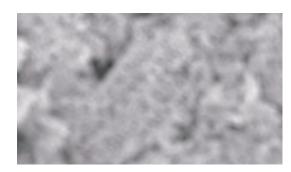
New GUI NanoStation 5.0 _

The NanoStation 5.0 has been improved and optimized for faster and more accurate analysis. It allows users to observe the shape of a sample and form an image in real-time on a quad display, and to combine SE and BSE signals into a single image for observation.



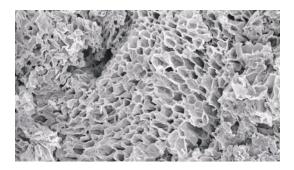
Auto Focus in 3 seconds _____

Auto Focus(AF) can dramatically reduce the time taken to analyze sample images.



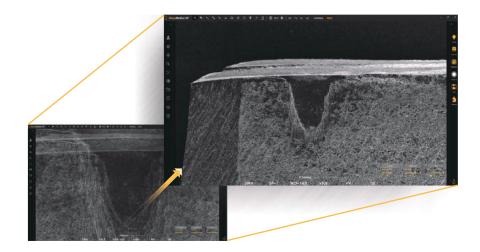


Auto Focus in 3 seconds



Fast scanning speed (ULTRA / TV / SLOW mode) _____

NanoStation 5.0 has greatly improved scanning speed compared to the existing EM series allowing users to select their preferred imaging speed to observe samples more quickly and clearly in various scan modes.



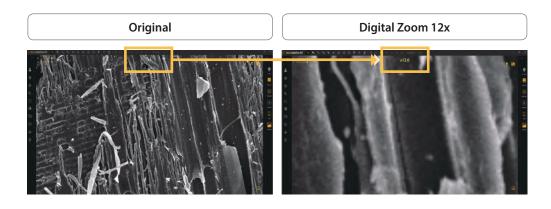
Motorized stage & Multi-sample holder

NanoStation 5.0 offers a motorized stage that allows the working distance between the lens and the sample on the Z-axis to be adjusted, thereby shortening the time required to analyze samples.



Archive editing function _

Users can re-edit the sample measurement, annotation, and other details of sample images saved in the archive. They can also enlarge saved images by up to 12 times using the digital zoom function.



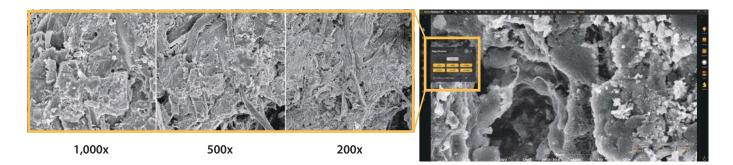
Location save function

When analyzing multiple samples, users can save up to 8 preferred analysis positions and quickly observe the samples by accurately moving to the saved positions.



ContinuousMagSave function _____

The ContinuousMagSave function allows users to directly set various magnifications at the desired position for analyzing samples, and images at the specified magnifications are automatically captured and saved.



Panorama v2

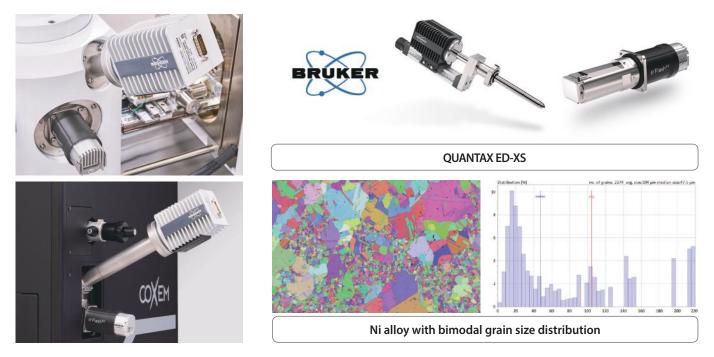
NanoStation 5.0 it offers it as a standard feature, and its upgraded stitching function enables users to acquire more precise and accurate images when analyzing large-area samples.



Options

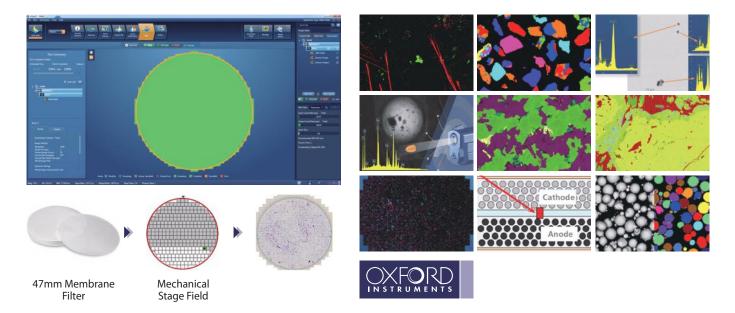
Compatible with compact EBSD

The EBSD obtains crystallographic data of a material by analyzing the diffraction pattern created by electrons backscattered from the sample surface by an incident electron beam. Coxem's EM-40, the world's first tabletop SEM to feature EBSD integration, along with the EBSD-integrated CX series, finds applications across diverse fields such as metallurgy, materials engineering, and geology.



Fast particle analysis

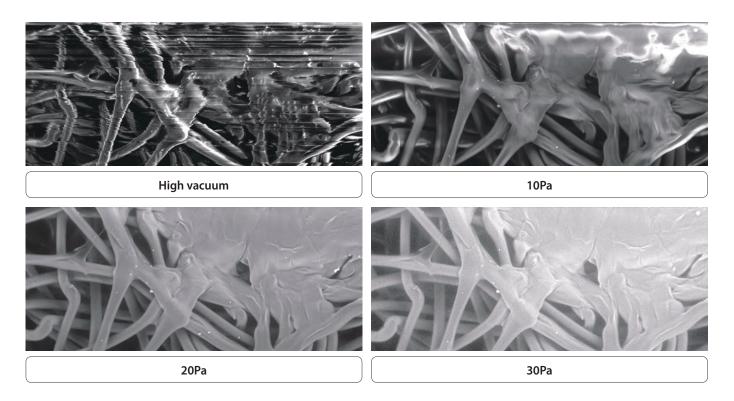
The improved scan speed enables rapid analysis of particles, and accurate analysis is possible not only when a sample consists of a single element but also when it comprises a mixture of elements.



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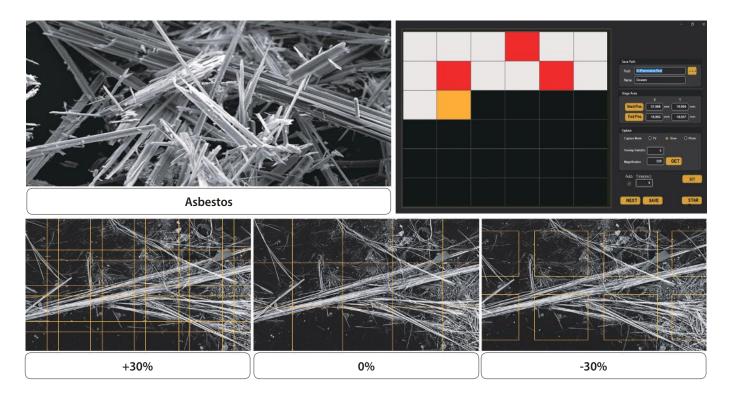
Variable pressure (10 / 20 / 30Pa) _____

The variable mode enables users to analyze biological samples or insulating materials without having to preprocess the sample.

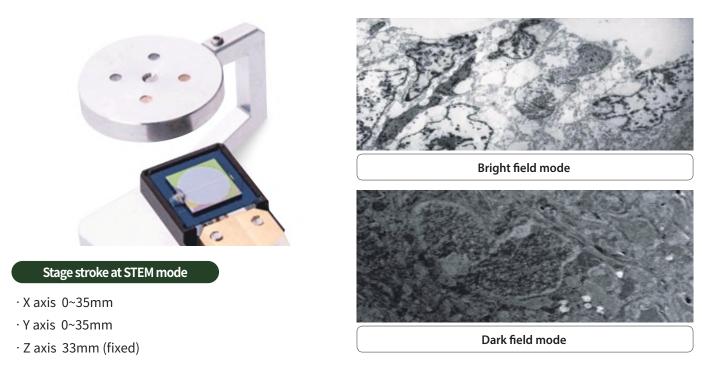


NanofiberScanner _____

The NanofiberScanner, Coxem's new analysis program, is ideal for analyzing asbestos. It allows users to save sample images and its positions immediately at the desired location during large-area analysis.



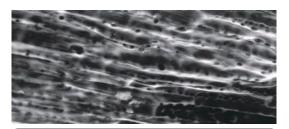
COXEM's SEM can perform STEM analysis by inserting a STEM detector and is capable of analyzing materials such as asbestos, cellular tissue, and nanostructures.



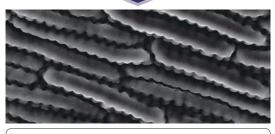
Coolstage _____

When observing a sample containing water, Coolstage lowers the sample temperature, thus obtaining analysis images without compromising the sample's unique microstructure and avoiding the complex sample preparation process of removing and fixing moisture.





Leaf without Coolstage



Leaf with Coolstage

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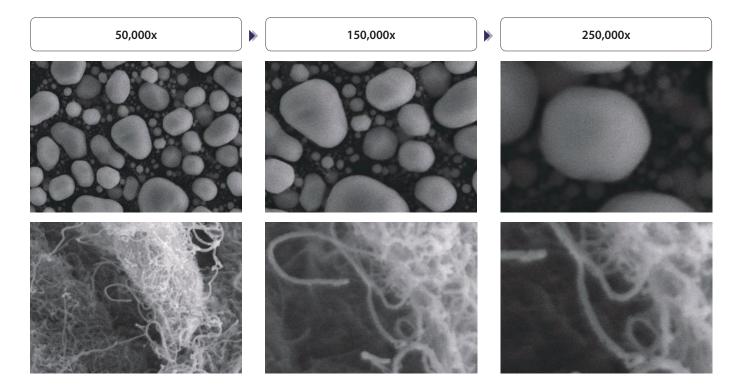
The Next Level of EM Series **EM-40**

- All-new GUI, NanoStation5
- Fast frame rate up to 13fps
- X, Y, Z axes motorized stage
- Variable pressure (10, 20, 30Pa)
- Compatible with compact EBSD
- Fast particle analysis with EDS



Perfect image quality across all magnification ranges

The EM-40 can observe samples at a high magnification up to 250,000x, allowing users to obtain high-resolution images effectively by adjusting the voltage, working distance, and size of the electron beam.



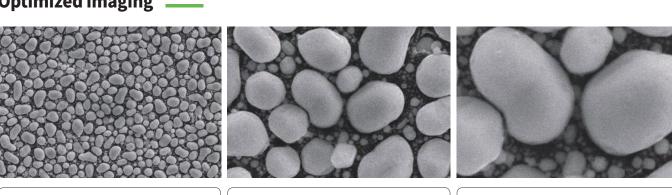
EM series

Model	EM-30N	EM-40
Electron gun	Tungsten filament (W)	Tungsten filament (W)
Spatial resolution	<5nm	<5nm
Photo magnification	15x to 150,000x	8x to 150,000x
Display magnification	15x to 150,000x	13x to 250,000x
Accelerating voltage	1~30kV	1~30kV
Sample stage	X : 35mm, Y : 35mm, Tilt : 0 ~ 45°	X : 40mm, Y : 40mm, Z : 40mm, 3-axis motorized
Detector	SE, BSE*	SE, BSE*
Vacuum mode	HV, LV*	HV, LV*, VP*
Vacuum system	Turbo pump (80L) + Rotary pump (100L)	Turbo pump (80L) + Rotary pump (100L)
Dimension	$400(W) \times 630(L) \times 600(H)mm, 85kg$	$315(W) \times 560(L) \times 580(H)mm, 81.5kg$
	Panorama v1	Panorama v2
Features	Auto focus	Auto focus
	Auto brightness & contrast	1 Second auto brightness & contrast
	Auto start	Auto start
	Signal mixing	Signal mixing
	Dual display & Save	Triple display & Save
	Line profile	Line profile
	Image filtering	Image filtering
	Annotation tool	Annotation tool
	ChamberCam	ChamberCam
Data output format	JPEG, TIFF, BMP	JPEG, TIFF, BMP
	BSE, EDS, EBSD, STEM	BSE, EDS, EBSD, STEM
Options*	NaviCam, Coolstage	NaviCam, Coolstage
	LV (20Pa)	LV (20Pa), VP (10 / 20 / 30Pa)
	Panorama v2, NanofiberScanner	NanofiberScanner
	Diaphragm pump	Diaphragm pump

The Standard, Yet Powerful

- All-new GUI, NanoStation5
- Maximum Mag. 500,000x
- Self-diagnostic system
- Optimized imaging
- 5-axis motorized stage
- Air-protection module
- A variety of options (EDS, EBSD, Coolstage, STEM etc)

Optimized imaging



Σ

X

000

10,000x

50,000x

100,000x

Stage control _____



 $\textbf{Home}: The \ coordinate \ 0.0 \ position \ of \ the \ stage$

NaviCam : Saves the actual sample image through the camera when loading the sample NaviCam

Center : Aligns the sample to the center position of the stage coordinates

Stop : Manually stops the movement of the stage

H.D (Home Disable) : Disables the axis of the stage from moving to the home position

 $\ensuremath{\operatorname{\mathsf{Move}}}$: Moves to the saved position of the sample

Modify : Edits the name of the sample

 ${\color{black} \textbf{Delete}:} \text{ Deletes the saved position of the sample}$

Graphic display according to the sample height and working distance

The Advanced Innovation **CX-300**

Advanced features

- Designed for Large-area
- Convenient working process with NaviCam, ChamberCam

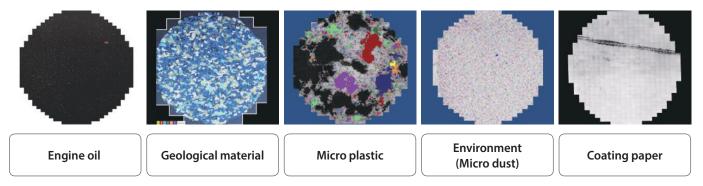


Large area analysis .

CX-300 provides a nano particle analysis solution that systematically classifies results including size, distribution, and composition of nano particles in large-area



Applications of large-area analysis



Air-protection module _____

For samples that react rapidly to air exposure, such as air-sensitive samples, preparation occurs within a specialized airprotection holder capable of maintaining a fully enclosed environment within a glove box filled with inert gases like nitrogen or argon. This prevents damage caused by exposure to air.

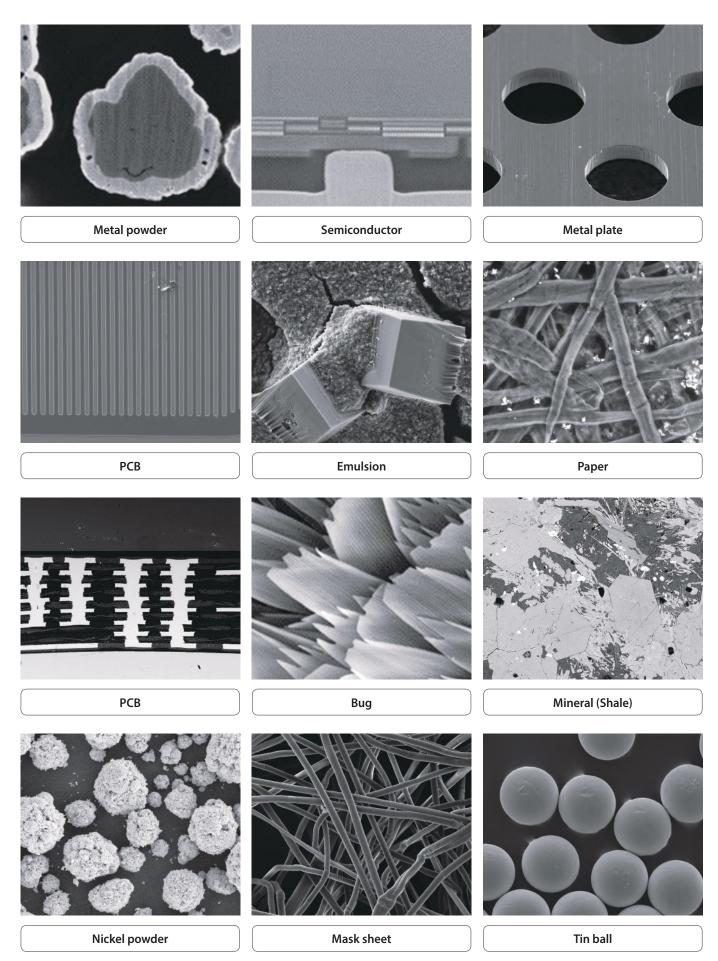
The sample can either be mounted directly onto Coxem's SEM for surface observation using the air protection holder, or it can be placed in an Ion Beam Polisher for cross-sectioning before observation in the SEM.



CX series

Model	СХ-200К	CX-300
Electron gun	Tungsten filament (W)	Tungsten filament (W)
Spatial resolution	<3nm	< 3nm
Photo magnification	6x to 300,000x	6x to 300,000x
Display magnification	9x to 500,000x	9x to 500,000x
Accelerating voltage	1~30kV	1~30kV
Sample stage	X : 60mm, Y : 60mm, Z : 60mm, R : 360, T : -20 ~ 90°	X : 100 mm, Y : 100mm, Z : 60mm, R : 360, T : -20 ~ 90°
Detector	SE, BSE	SE, BSE
Vacuum mode	HV, LV(20Pa)*, VP(10, 20, 30Pa)*	HV, LV(20Pa)*, VP(10, 20, 30Pa)*
Vacuum system	Turbo pump (80L) + Rotary pump (100L)	Turbo pump (80L) + Rotary pump (100L)
Dimension	$640(W) \times 682(L) \times 1,432(H)mm,200kg$	$640(W) \times 690(L) \times 1,460(H)mm, 200kg$
Features	Panorama v2	Panorama v2
	Auto focus	Auto focus
	Auto brightness & contrast	1 Second auto brightness & contrast
	Auto start	Auto start
	Signal mixing	Signal mixing
	Triple display & Save	Quad display & Save
	Line profile	Line profile
	Image filtering	Image filtering
	Annotation tool	Annotation tool
	ChamberCam	ChamberCam
Data output format	JPEG, TIFF, BMP	JPEG, TIFF, BMP
Options*	EBSD, STEM	EBSD, STEM
	Coolstage	NaviCam, Coolstage
	LV(20Pa), VP(10 / 20 / 30Pa)	LV(20Pa), VP(10 / 20 / 30Pa)
	NanofiberScanner	NanofiberScanner
	Scroll pump	Scroll pump

Applications _____



Powerful Sample Preparation Instrument : Ion Sputter Coater SPT-20

SPT-20 protects the sample from surface damage by sputtering a thin layer of conductive material onto it, allowing for higher-quality SEM images. SPT-20 is well-suited for preparing samples for both tungsten SEM and Tabletop SEM analysis.





Features

- \cdot Compact and cost-effective solution
- \cdot One-touch operation from the LCD touch panel
- · Stable coating with current feedback function
- · Various metal targets available : Au, Pt, Pt-Pd



Specification _____

50mm dia. 0.1mm thickness, 99.9%

lon sputter coater system :

Dimension & Weight	420(W) \times 220(L) \times 230(H)mm, 10kg	
Power consumption	AC 110 or 220V, 50/60 Hz, 300W	
Chamber size	Ø100mm	
Target size	50mm	
Target	Au, Pt, Pt-Pd	
Operating vacuum	0.1 Torr	
Maximum Ion voltage	3kV	
lon current	0~9mA	
Coating time	10 ~ 300sec	
Pump system :		
Vacuum pump set	Rotary vacuum pump (50L)	
Pump dimension & Weight	$120(W) \times 373.5(D) \times 200(H)mm, 14kg$	
Power consumption	AC 110V or 220V, 50/60Hz, 0.12kW	

Ion Beam Polisher



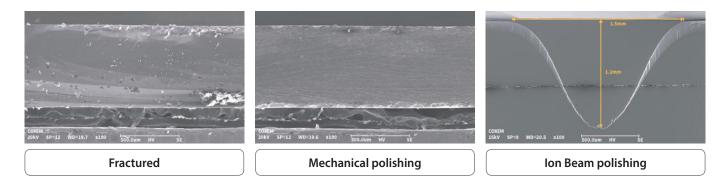
The IP-10K is COXEM's upgraded Ion Beam Polisher, equipped with various options including flat-milling, cooling stage, and the air-protection module, ensuring enhanced performance and versatility for a wide range of applications. It offers unparalleled capabilities for the precision milling of materials at the microscale levels, providing exceptional cleanliness and accuracy.

Features

- A fast milling speed of 1,000um/h (Si, 8kV)
- Minimizes thermal damage with the cooling stage
- Air-protection module compatible with SEM
- Flat-milling function provided for planar etching
- A fast pump/vent time with easy sample loading
- Higher front mask usability

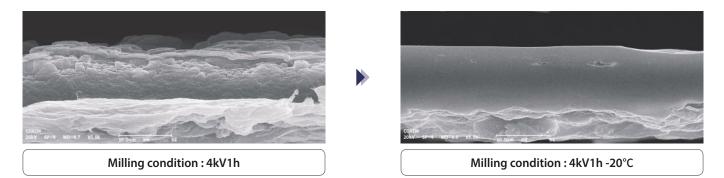
Ion beam polishing _____

It is evident how much cleaner the cross-section surface appears after ion beam polishing compared to images of fractured or mechanically polished samples.



Cooling module _____

When working with heat-vulnerable samples, the risk of heat damage can be minimized by using a Peltier-type cooling stage, capable of cooling the stage down to -20°C.

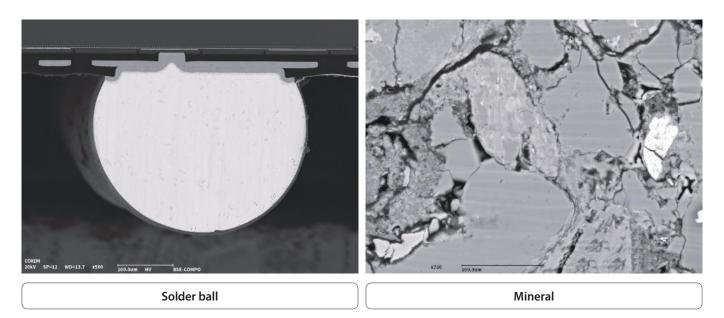


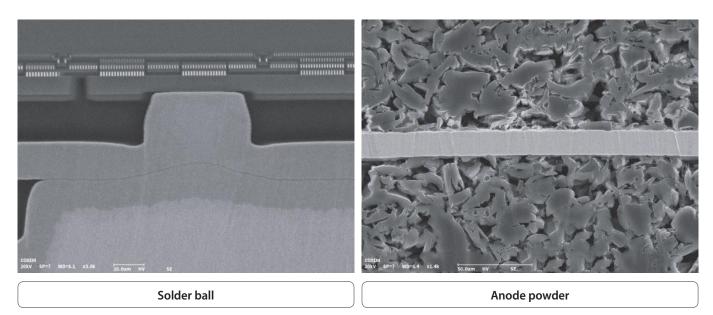
Air-protection module _____

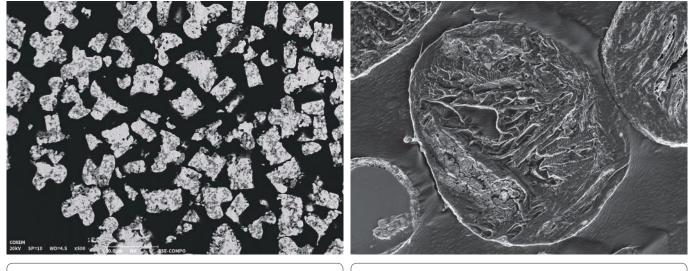
When the sample is susceptible to deformation in the air, the air protection option proves highly beneficial. This option allows milling and observation of the sample to be completed without exposure to the air.



Applications _____





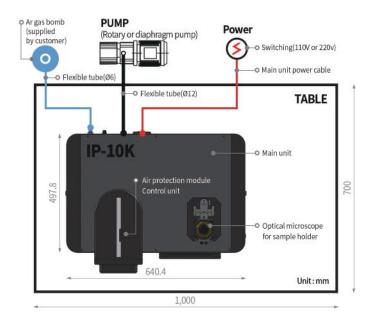


Metal Powder

Anode powder

Specifications _____

Ion accelerating voltage	2 to 8kV
Milling speed	1,000um/h (at 8kV on Si wafer)
Sample stage swing angle	±35°
Maximum sample size	$\begin{array}{l} 20(W)\times10(L)\times5.5(T)mm\\ 16(W)\times10(D)\times9.5(H)mm \end{array}$
Specimen movement range	X axis movement : ±3.5mm Y axis movement : ±2mm
Flat milling stage tilt angle range	10° to 90°
Sample size for flat milling	Ø32 × 18(H)mm
Operation	7 inch touch panel
Digital microscope for sample positioning	Mag. 5x, 10x, 20x, 40x
Chamber camera for monitoring	Mag. 5x, 10x, 20x, 40x Brightness adjustable in 4 steps Ion beam observation mode (LED off)
Gas used	Argon gas (99.999%)
Gas pressure	0.03MPa ~ 0.05MPa
Gas flow control	Mass Flow Control unit
Vacuum systems	Turbo pump, Diaphragm pump
Dimension	640(W) × 492(D) × 282(465)(H)mm
Weight	Main system 45kg / Diaphragm pump 6.5kg
Options	Air-protection module, Cooling module, Flat milling







We used paper certified by FSC®



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